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Index	ExType	L #	Hits	Search Text	DBs	Time Stamp	Comments
1	IS&R	L1	2745	(382/141-149).CCLS.	US- PGPUB; USPAT	2007/02/08 10:44	
2	IS&R	L2	173	(348/92).CCLS.	US- PGPUB; USPAT	2007/02/08 10:44	
3	BRS	L3	33	(3-d or 3d or (three near1 dimension\$3)) same imag\$3 same (part\$1 or manufactured) same (flaw\$1 or defect\$4 or crack\$1 or void\$1) same (identif\$6 or match\$4 or compar\$6 or collat\$4 or correlat\$4) same (locat\$4 or position\$3 or spatial or co-ordinate\$1 or coordinate\$1)	US- PGPUB; USPAT	2007/02/08 11:00	
4	BRS	L4	17	3 same (inspect\$4 or test\$3 or evaluat\$4 or qualit\$6)	US- PGPUB; USPAT	2007/02/08 10:49	
5	BRS	L6	0	2 and 4	US- PGPUB; USPAT	2007/02/08 10:50	
6	BRS	L5	7	1 and 4	US- PGPUB; USPAT	2007/02/08 10:58	
7	BRS	L7	4281	display\$3 with (part\$1 or image\$1) with (flaw\$1 or void\$1 or defect\$4)	US- PGPUB; USPAT	2007/02/08 10:59	

	Type	L #	Hits	Search=Text	DBs	Time Stamp	Comments
8	BRS	L8	111	7 same (3-d or 3d or (three near1 dimension\$3))	US- PGPUB; USPAT	2007/02/08 11:59	
9	BRS	L9	47	8 same (measur\$6 or inspect\$4 or test\$4)	US- PGPUB; USPAT	2007/02/08 11:01	
10	BRS	L10	7	9 same (recogn\$6 or identif\$7 or judg\$6)	US- PGPUB; USPAT	2007/02/08 11:09	
11	BRS	L11	5	(identif\$6 near3 (flaw\$1 or defect\$4 or void\$1 or crack\$1)) same (align\$5 or documented or documenting or correct\$3) same (inspect\$4 or test\$3) same imag\$3 same ((three near1 dimension\$3) or 3d or 3-d)	US- PGPUB; USPAT	2007/02/08 11:14	
12	IS&R	L12	615	(382/149).CCLS.	US- PGPUB; USPAT	2007/02/08 11:15	
13	BRS	L13	898	7 same (user\$2 or operator\$2 or expert\$2)	US- PGPUB; USPAT	2007/02/08 11:15	
14	BRS	L14	18	13 same cad	US- PGPUB; USPAT	2007/02/08 11:15	
15	BRS	L15	1	12 and 14	US- PGPUB; USPAT	2007/02/08 11:17	

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16	BRS	L16	67	12 and 13	US- PGPUB; USPAT	2007/02/08 11:17	
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18	BRS	L18	15	16 and (three near2 dimension\$3)	US- PGPUB; USPAT	2007/02/08 11:35	
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21	BRS	L21	1	portable adj nondestructive adj examin\$6	US- PGPUB; USPAT	2007/02/08 11:56	
22	BRS	L22	14	marian and (part\$1 near9 inspect\$5)	US- PGPUB; USPAT	2007/02/08 11:57	
23	BRS	L23	7	22 and (3-d or 3d or (three near1 dimension\$3))	US- PGPUB; USPAT	2007/02/08 12:02	
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26	BRS	L26	265	25 same imag\$3	US- PGPUB; USPAT	2007/02/08 12:01	
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<p><u>L6</u> 6173066.pn.</p>	<p>1</p>	<p><u>L6</u></p>
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<u>L7</u>	L2 same ((cad or 3d or 3-d or (stl near1 format) or (three near1 dimension\$3)) near5 (model or representation or template or reference or prestored or stored or known))	14	<u>L7</u>
<u>L8</u>	L1 same ((cad or 3d or 3-d or (stl near1 format) or (three near1 dimension\$3)) near5 (model or representation or template or reference or prestored or stored or known))	17	<u>L8</u>
<u>L9</u>	L8 same (inspect\$4 or test\$3)	17	<u>L9</u>
<u>L10</u>	l1 same manufactur\$3	262	<u>L10</u>
<u>L11</u>	l10 same ((locat\$4 or identif\$4 or detect\$4 or judg\$5) near4 (flaw\$1 or defect\$4 or crack\$1 or void\$1 or (lack near1 fusion near1 weld) or (incomplete\$1 near1 weld) or rivet))	122	<u>L11</u>
<u>L12</u>	L11 same (flaw\$1 or defect\$4 or void)	121	<u>L12</u>
<u>L13</u>	l12 same ((cad or 3d or 3-d or (stl near1 format) or (three near1 dimension\$3)) near5 (model or representation or template or reference or prestored or stored or known))	1	<u>L13</u>
<u>L14</u>	L12 same ((test\$3 or inspect\$4) near7 part\$1)3	0	<u>L14</u>
<u>L15</u>	L12 same ((test\$3 or inspect\$4) near7 part\$1)	33	<u>L15</u>
<u>L16</u>	l15 and ((cad or 3d or 3-d or (stl near1 format) or (three near1 dimension\$3)) near5 (model or representation or template or reference or prestored or stored or known))	5	<u>L16</u>
<u>L17</u>	l12 same ((creat\$4 or generat\$4) near5(cad or 3d or 3-d or (stl near1 format) or (three near1 dimension\$3)))	0	<u>L17</u>
<u>L18</u>	l12 same (3d or 3-d or (stl near1 format) or (three near1 dimension\$3))	5	<u>L18</u>
<u>L19</u>	((identif\$6 or locat\$4 or judg\$5) near5 (flaw\$1 or defect\$4 or void)) same imag\$3 same (inspect\$4 or test\$4) same (3d or 3-d or (three near1 dimension\$3))	66	<u>L19</u>
<u>L20</u>	L19 same part\$1	8	<u>L20</u>
<u>L21</u>	("5774568" "6118540" "6341153" "6466643" "6539107" "6614872" "6618465").PN.	7	<u>L21</u>
<u>L22</u>	l2 and L21	0	<u>L22</u>
<u>L23</u>	l1 and L21	0	<u>L23</u>
<u>L24</u>	l21 and ((locat\$4 or identif\$4 or detect\$4 or judg\$5) near4 (flaw\$1 or defect\$4 or crack\$1 or void\$1 or (lack near1 fusion near1 weld) or (incomplete\$1 near1 weld) or rivet))	6	<u>L24</u>
<u>L25</u>	l24 and ((3d or 3-d or (stl near1 format) or (three near1 dimension\$3)) near7 (model or template or stored or reference or represent\$6 or prestored or known))	3	<u>L25</u>

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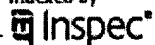
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